IR2153

SELF-OSCILLATING HALF-BRIDGE DRIVER

Features

- Floating channel designed for bootstrap operation Fully operational to +600V

 Tolerant to negative transient voltage dV/dt immune
- Undervoltage lockout
- Programmable oscillator frequency

$$f = \frac{1}{1.4 \times (R_T + 75\Omega) \times C_T}$$

- Matched propagation delay for both channels
- Micropower supply startup current of 90 µA.
- Shutdown function turns off both channels
- Low side output in phase with R_T

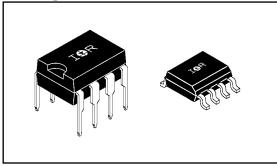
Description

The IR2153 is a high voltage, high speed, self-oscillating power MOSFET and IGBT driver with both high and low side referenced output channels. Proprietary HVIC and latch immune CMOS technologies enable ruggedized monolithic construction. The front end features a programmable oscillator which is similar to the 555 timer. The output drivers feature a high pulse current buffer stage and an internal deadtime designed for minimum driver cross-conduction. Propagation delays for the two channels are matched to simplify use in 50% duty cycle applications. The floating channel can

Product Summary

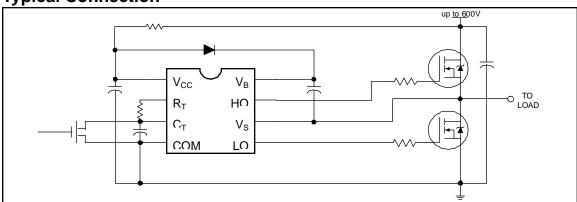
Voffset	600V max.
Duty Cycle	50%
l _O +/-	200 mA / 400 mA
V _{clamp}	15.6V
Deadtime (typ.)	1.2 µs

Packages



be used to drive an N-channel power MOSFET or IGBT in the high side configuration that operates off a high voltage rail up to 600 volts.

Typical Connection



Absolute Maximum Ratings

Absolute Maximum Ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM. The Thermal Resistance and Power Dissipation ratings are measured under board mounted and still air conditions.

Parameter			Va		
Symbol	Definition		Min.	Max.	Units
V _B	High Side Floating Supply Voltage		-0.3	625	
Vs	High Side Floating Supply Offset Voltage		V _B - 25	V _B + 0.3	
V _{HO}	High Side Floating Output Voltage		V _S - 0.3	V _B + 0.3	v
V _{LO}	Low Side Output Voltage		-0.3	V _{CC} + 0.3	V
V _{RT}	R _T Voltage		-0.3	V _{CC} + 0.3	
V _{CT}	C _T Voltage		-0.3	V _{CC} + 0.3	
Icc	Supply Current (Note 1)		_	25	mA
I _{RT}	R _T Output Current		-5	5	IIIA
dV _s /dt	Allowable Offset Supply Voltage Transient		_	50	V/ns
PD	Package Power Dissipation @ T _A ≤ +25°C	(8 Lead DIP)	_	1.0	w
		(8 Lead SOIC)	_	0.625	VV
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(8 Lead DIP)	_	125	°C/W
		(8 Lead SOIC)	_	200	C/VV
TJ	Junction Temperature		_	150	
T _S	Storage Temperature		-55	150	°C
TL	Lead Temperature (Soldering, 10 seconds)		_	300	

Recommended Operating Conditions

The Input/Output logic timing diagram is shown in Figure 1. For proper operation the device should be used within the recommended conditions. The V_S offset rating is tested with all supplies biased at 15V differential.

	Parameter	Va		
Symbol	Definition	Min.	Max.	Units
V _B	High Side Floating Supply Absolute Voltage	V _S + 10	V _S + 20	
Vs	High Side Floating Supply Offset Voltage	_	600	V
V _{HO}	High Side Floating Output Voltage	٧s	V _B] V
V_{LO}	Low Side Output Voltage	0	V _{CC}	
Icc	Supply Current (Note 1)	_	5	mA
T _A	Ambient Temperature	-40	125	°C

Note 1: Because of the IR2153's application specificity toward off-line supply systems, this IC contains a zener clamp structure between the chip V_{CC} and COM which has a nominal breakdown voltage of 15.6V. Therefore, the IC supply voltage is normally derived by forcing current into the supply lead (typically by means of a high value resistor connected between the chip V_{CC} and the rectified line voltage and a local decoupling capacitor from V_{CC} to COM) and allowing the internal zener clamp circuit to determine the nominal supply voltage. Therefore, this circuit should not be driven by a DC, low impedance power source of greater than V_{CL AMP}.

Dynamic Electrical Characteristics

 V_{BIAS} (V_{CC}, V_{BS}) = 12V, C_L = 1000 pF and T_A = 25°C unless otherwise specified.

Parameter		Value				
Symbol Definition		Min.	Тур.	Max.	Units	Test Conditions
t _r	Turn-On Rise Time	_	80	_		
t _f	Turn-Off Fall Time	_	35	_	ns	
t _{sd}	Shutdown Propagation Delay	_	660	_		
DT	Deadtime	_	1.2	_	μs	
D	R _T Duty Cycle	_	50	_	%	

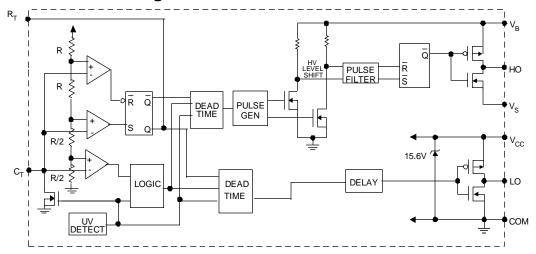
Static Electrical Characteristics

 V_{BIAS} (V_{CC} , V_{BS}) = 12V, C_L = 1000 pF, C_T = 1 nF and T_A = 25°C unless otherwise specified. The V_{IN} , V_{TH} and I_{IN} parameters are referenced to COM. The V_O and I_O parameters are referenced to COM and are applicable to the respective output leads: HO or LO.

Parameter		Value				
Symbol	Definition	Min.	Тур.	Max.	Units	Test Conditions
fosc	Oscillator Frequency	T —	20.0	_	1.11=	$R_T = 35.7 \text{ k}\Omega$
		_	100	_	kHz	$R_T = 7.04 \text{ k}\Omega$
V _{CLAMP}	V _{CC} Zener Shunt Clamp Voltage	_	15.6	_		$I_{CC} = 5 \text{ mA}$
V _{CT+}	2/3 V _{CC} Threshold	_	8.0	_	V	
V _{CT-}	1/3 V _{CC} Threshold	_	4.0	_	V	
V _{CTSD}	C _T shutdown Input Threshold	_	2.2	_		
V _{RT+}	R _T High Level Output Voltage, V _{CC} - R _T	-	0	100		I _{RT} = -100 μA
			200	300		I _{RT} = -1 mA
V _{RT-}	R _T Low Level Output Voltage	_	20	50		I _{RT} = 100 μA
		_	200	300	mV	I _{RT} = 1 mA
V _{OH}	High Level Output Voltage, V _{BIAS} - V _O	_	_	100	1111	I _O = 0A
V_{OL}	Low Level Output Voltage, V _O	_	_	100		$I_O = 0A$
I _{LK}	Offset Supply Leakage Current	_	_	50		$V_{B} = V_{S} = 600V$
I_{QBS}	Quiescent V _{BS} Supply Current	-	10	_		
I _{QCCUV}	Micropower V _{CC} Supply Startup Current	_	90	_	цΑ	V _{CC} < V _{CCUV}
I _{QCC}	Quiescent V _{CC} Supply Current	_	400	_		V _{CC} > V _{CCUV}
I _{CT}	C _T Input Current	-	0.001	1.0		
V _{CCUV+}	V _{CC} Supply Undervoltage Positive Going	-	9.0	_		
	Threshold				V	
V _{CCUV-}	V _{CC} Supply Undervoltage Negative Going	_	8.0	_		
	Threshold					
V _{CCUVH}	V _{CC} Supply Undervoltage Lockout Hysteresis	-	1.0	_	V	
I _{O+}	Output High Short Circuit Pulsed Current	_	200	_	mA	$V_O = 0V$
I _{O-}	Output Low Short Circuit Pulsed Current	_	400	_		V _O = 15V

International TOR Rectifier

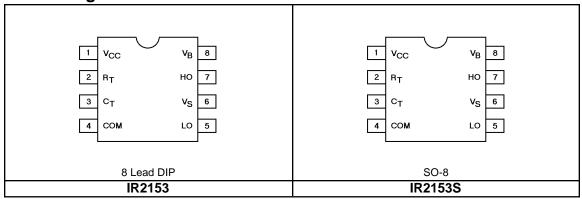
Functional Block Diagram



Lead Definitions

Le	ead					
Symbol	Description					
R _T	Oscillator timing resistor input,in phase with HO for normal IC operation					
C _T	Oscillator timing capacitor input, the oscillator frequency according to the following equation:					
	$f = \frac{1}{1.4 \times (R_T + 75\Omega) \times C_T}$					
	where 75 Ω is the effective impedance of the R _T output stage					
V _B	High side floating supply					
НО	High side gate drive output					
VS	High side floating supply return					
Vcc	Low side and logic fixed supply					
LO	Low side gate drive output					
COM	Low side return					

Lead Assignments



Device Information

Process & Design Rule			HVDCMOS 4.0 μm		
Transistor Count			231		
Die Size			68 X 101 X 26 (mil)		
Die Outline					
Thickness of	of Gate Oxide		800Å		
Connection	S	Material	Poly Silicon		
	First	Width	5 μm		
	Layer	Spacing	6 μm		
	•	Thickness	5000Å		
		Material	Al - Si - Cu (Si: 1.0%, Cu: 0.5%)		
	Second	Width	6 μm		
	Layer	Spacing	9 μm		
		Thickness	20,000Å		
Contact Ho	le Dimension		5 μm X 5 μm		
Insulation L	ayer	Material	PSG (SiO ₂)		
		Thickness	1.7 μm		
Passivation		Material	PSG (SiO ₂)		
		Thickness	1.7 μm		
Method of S	Saw		Full Cut		
Method of D	Die Bond		Ablebond 84 - 1		
Wire Bond		Method	Thermo Sonic		
			Au (1.0 mil / 1.3 mil)		
Leadframe		Material	Cu		
		Die Area	Ag		
			Pb : Sn (37 : 63)		
Package	Package Types		8 Lead PDIP / SO-8		
	Materia		EME6300 / MP150 / MP190		
Remarks:					

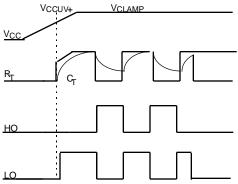


Figure 1. Input/Output Timing Diagram

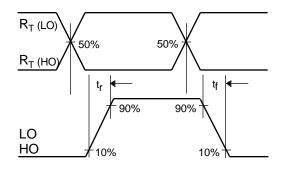


Figure 2. Switching Time Waveform Definitions

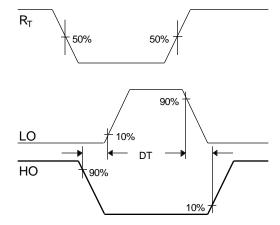
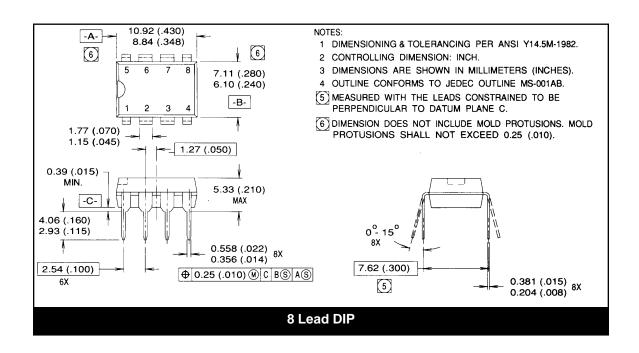
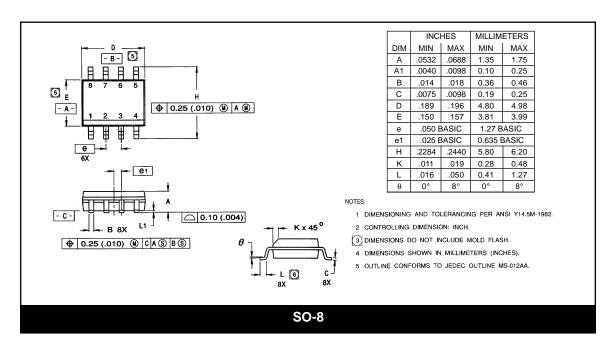


Figure 3. Deadtime Waveform Definitions





International

TOR Rectifier

IR2153



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